

# GSM1073KJZF

## 20V P-Channel Enhancement Mode MOSFET

### Product Description

GSM1073KJZF, P-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge.

These devices are particularly suited for low voltage power management, such as smart phone and notebook computer, and low in-line power loss are needed in commercial industrial surface mount applications.

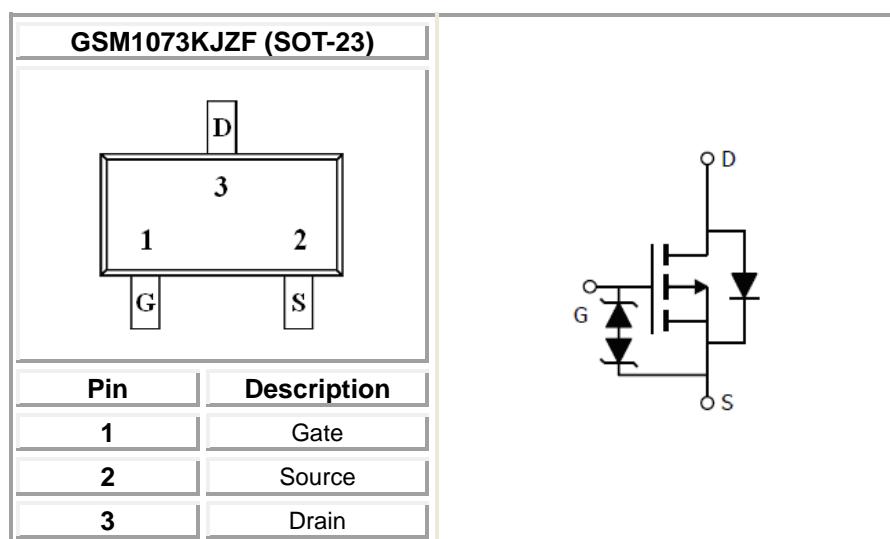
### Features

- -20V/-0.5A,  $R_{DS(ON)}=800m\Omega @ V_{GS}=-4.5V$
- -20V/-0.2A,  $R_{DS(ON)}=1100m\Omega @ V_{GS}=-2.5V$
- -20V/-0.1A,  $R_{DS(ON)}=1800m\Omega @ V_{GS}=-1.8V$
- Low-Voltage Operation
- High-Speed Circuits
- ESD Protection
- SOT-23 package design

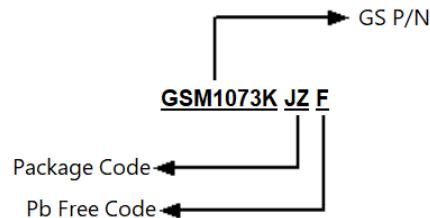
### Applications

- Drivers : Relays, Solenoids, Lamps, Hammers
- Battery Operated Systems
- Power Supply Converter Circuits
- Load/Power Switching Smart Phones, Pagers

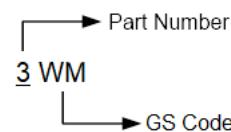
### Packages & Pin Assignments



## Ordering Information



## Marking Information



Part Number	Package	Part Marking
GSM1073KJZF	SOT-23	<u>3</u> WM

## Absolute Maximum Ratings

( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Typical	Unit
$V_{DSS}$	Drain-Source Voltage	-20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 8$	V
$I_D$	Continuous Drain Current( $T_J=150^\circ\text{C}$ )	$T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	-0.6 -0.5
$I_{DM}$	Pulsed Drain Current	-1.9	A
$P_D$	Power Dissipation	$T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	0.45 0.29
$R_{\theta JA}$	Thermal Resistance Junction to ambient	275	$^\circ\text{C}/\text{W}$
$T_J$	Operating Junction Temperature Range	-55 to +150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^\circ\text{C}$

## Electrical Characteristics

( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_D=-250\mu\text{A}$	-20			V
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_D=-250\mu\text{A}$	-0.3		-1.0	
$I_{\text{GSS}}$	Gate Leakage Current	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=\pm 8\text{V}$			$\pm 10$	$\mu\text{A}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-20\text{V}, V_{\text{GS}}=0\text{V}$			-1	$\mu\text{A}$
		$V_{\text{DS}}=-16\text{V}, V_{\text{GS}}=0\text{V}$ $T_J=85^\circ\text{C}$			-30	
$R_{\text{DS}(\text{on})}$	Drain-Source On-Resistance	$V_{\text{GS}}=-4.5\text{V}, I_D=-0.5\text{A}$		550	800	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}, I_D=-0.2\text{A}$		760	1100	
		$V_{\text{GS}}=-1.8\text{V}, I_D=-0.1\text{A}$		1000	1800	
		$V_{\text{GS}}=-1.5\text{V}, I_D=-0.1\text{A}$		1230	2600	
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}}=-10\text{V}, I_D=-0.3\text{A}$		0.8		S
$V_{\text{SD}}$	Diode Forward Voltage	$I_S=-0.5\text{A}, V_{\text{GS}}=0\text{V}$			-1.3	V
<b>Dynamic</b>						
$Q_g$	Total Gate Charge	$V_{\text{DS}}=-10\text{V}, V_{\text{GS}}=-4.5\text{V}, I_D=-0.25\text{A}$		0.62		$\text{nC}$
$Q_{\text{gs}}$	Gate-Source Charge			0.1		
$Q_{\text{gd}}$	Gate-Drain Charge			0.13		
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=-16\text{V}, V_{\text{GS}}=0\text{V}$ $f=1\text{MHz}$		59.8		$\text{pF}$
$C_{\text{oss}}$	Output Capacitance			12.1		
$C_{\text{rss}}$	Reverse Transfer Capacitance			6.4		
$t_{\text{d}(\text{on})}$	Turn-On Time	$V_{\text{DD}}=-10\text{V}, R_L=47\Omega, I_D=0.2\text{A}$ $V_{\text{GEN}}=-4.5\text{V}, R_G=10\Omega$		5.1		$\text{ns}$
$t_r$				8.1		
$t_{\text{d}(\text{off})}$	Turn-Off Time			28.4		
$t_f$				20.7		

## Typical Performance Characteristics

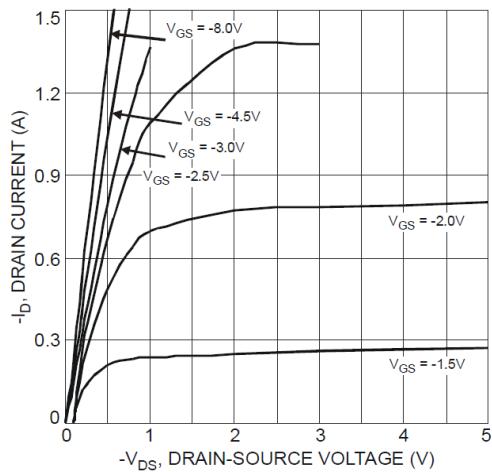


Fig. 1 Typical Output Characteristics

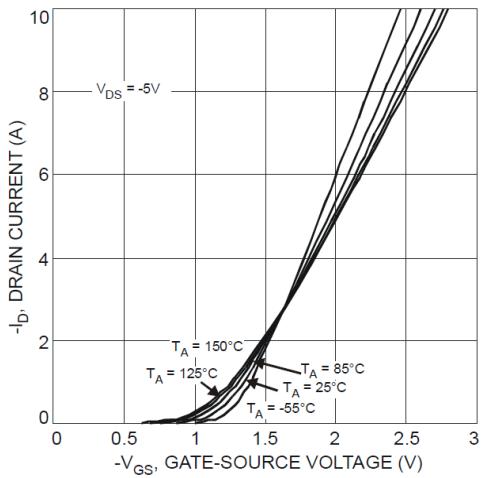


Fig. 2 Typical Transfer Characteristics

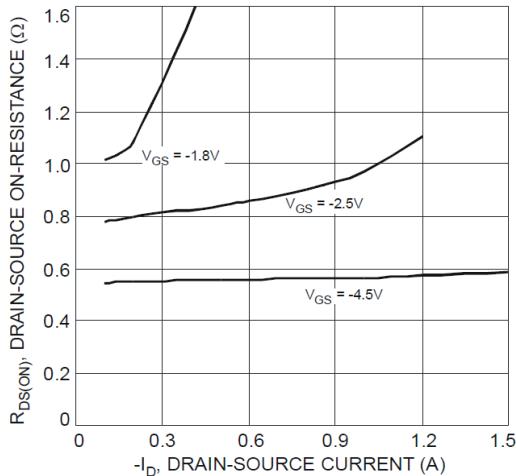


Fig. 3 Typical On-Resistance vs.  $I_D$  and  $V_{GS}$

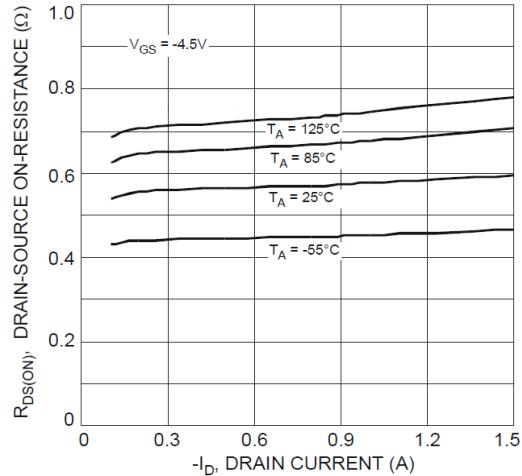


Fig. 4 Typical Drain-Source On-Resistance vs.  $I_D$  and  $T_A$

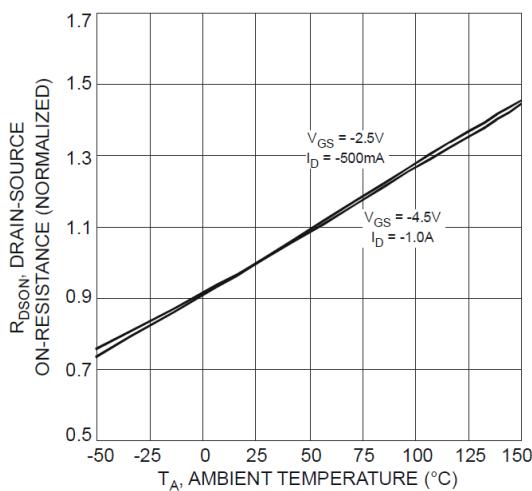


Fig. 5 On-Resistance Variation with  $T_J$

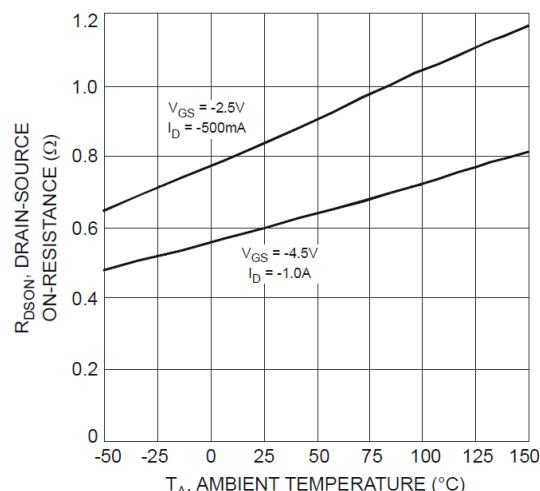


Fig. 6 On-Resistance Variation with  $T_J$

## Typical Performance Characteristics (continue)

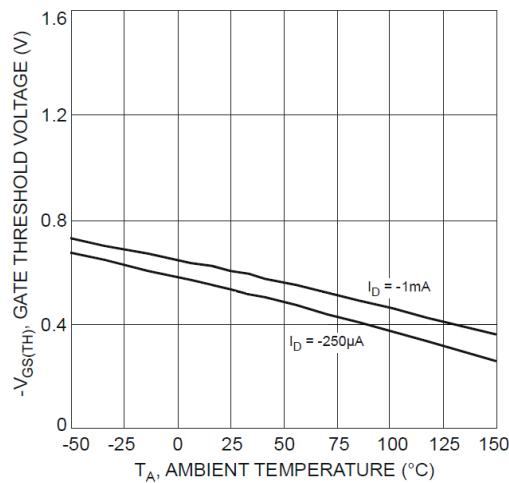


Fig. 7 Gate Threshold Variation vs.  $T_A$

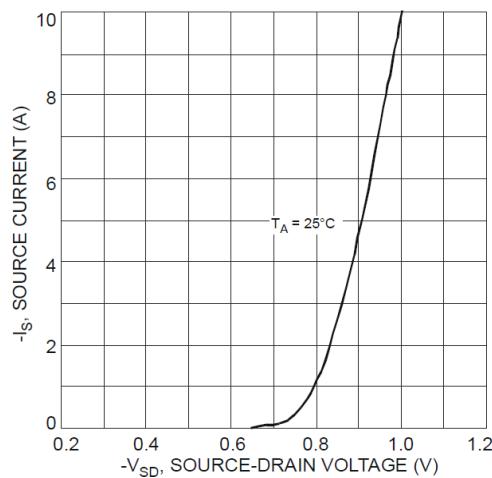


Fig. 8 Diode Forward Voltage vs. Current

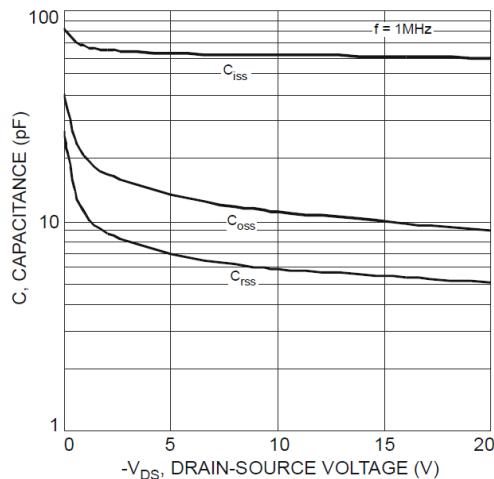


Fig. 9 Typical Capacitance

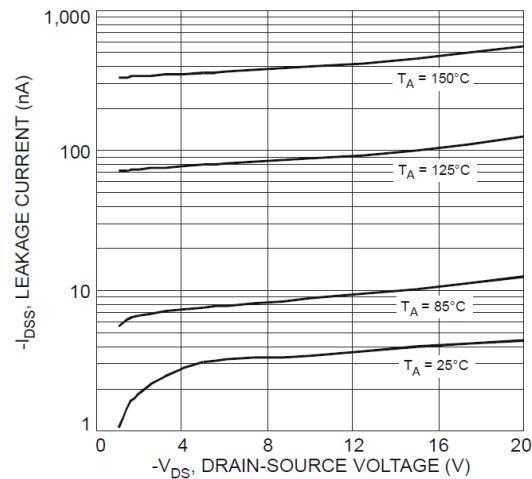


Fig. 10 Typical Drain-Source Leakage Current vs. Drain-Source Voltage

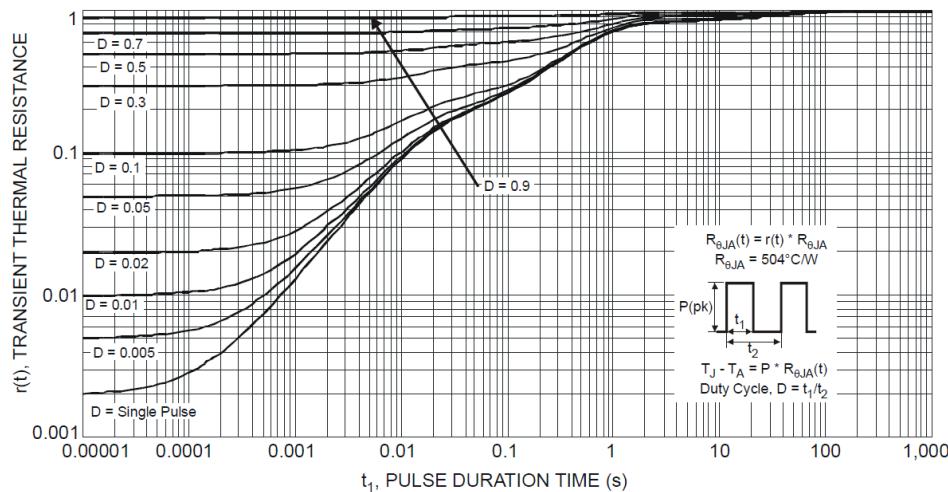
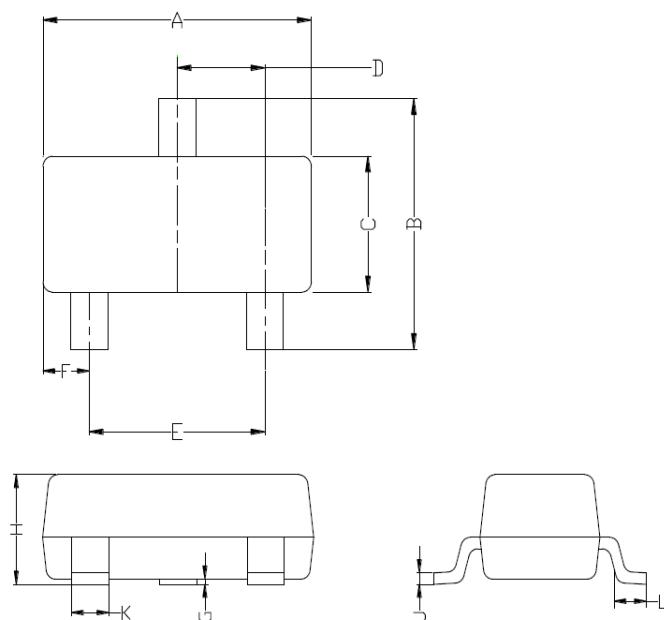


Fig. 11 Transient Thermal Response

## Package Dimension

### SOT-23



### Dimensions

Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	2.800	3.040	0.110	0.119
B	2.100	2.640	0.083	0.104
C	1.200	1.400	0.047	0.055
D	0.890	1.030	0.035	0.041
E	1.780	2.050	0.070	0.080
F	0.450	0.600	0.018	0.024
G	0.013	0.100	0.001	0.004
H	0.900	1.110	0.035	0.043
J	0.085	0.180	0.003	0.007
K	0.370	0.510	0.015	0.020
L	0.300	0.550	0.012	0.022

GSM1073KJZF

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